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Pressure-induced metallization of BaMn₂As₂

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Temperature- and pressure-dependent electrical resistivity $[(\rho T, P)]$ studies have been performed on BaMn₂As₂ single crystal in the 4.2–300 K range up to 8.2 GPa in order to investigate the evolution of its ground state properties. $\rho(T)$ data show negative coefficients of resistivity up to a pressure of 3.2 GPa. At a pressure of ~4.5 GPa an insulator-to-metal transition is seen to occur at ~36 K, as indicated by a change in the temperature coefficient of the $\rho(T)$. However, at a pressure of ~5.8 GPa the sample is metallic in the entire temperature range. X-ray diffraction studies performed as a function of pressure, at room temperature, also show an anomaly in the pressure versus volume curve around $P \approx 5$ GPa without a change in crystal structure, indicative of an electronic transition in support of the resistivity results. In addition to metallization, a clear precipitous drop in $\rho(T)$ is seen at ~17 K for $P \ge 5.8$ GPa.

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The hectic pace of research fueled by the discovery of superconductivity in the FeAs compounds both by electron and hole doping,¹ by the application of pressure²⁻⁴ and iso-electronic substitutions,^{2,5} has provided impetus to search for superconductivity in compounds with similar structures.¹ Of these classes of compounds BaMn₂As₂ is interesting as it occurs in an antiferromagnetic insulating ground state.^{6–8} The Mn atoms in this structure order antiferromagnetically in a checkerboard fashion termed as G-type antiferromagnet, with the spins aligned collinear to the c axis.⁸ The Néel temperature is 625 K.⁸ The local moment at the Mn site is large, $\sim 3.88 \mu_B$ (Ref. 8), contrary to the small moment of 0.9 μ_B per Fe atom¹ seen in the spin density wave ground state of BaFe₂As₂. Resistivity and specific heat measurements⁹ on flux-grown single crystals indicate that the compound is a small-band-gap semiconductor. Band structure calculations also indicate that BaMn₂As₂ is antiferromagnetic and has a semiconducting band gap of 0.2 eV.⁹ It has been suggested that doping BaMn₂As₂ with carriers can induce large antiferromagnetic fluctuations in the metallic compound and can lead to an exotic superconducting ground state, with a larger T_C as compared to that seen in BaFe₂As₂.¹ With this in view, several transition metals were doped at the Mn site, but the solubility turned out to be negligible and no metallicity could be obtained for substitutions with Cr, Fe, Co, Ni, Cu, Ru, Rh, Pd, Re, and Pt at the Mn site nor Sb at the As site.¹⁰ Several investigations^{10,11} of Ba(Fe_{1-x}Mn_x)₂As₂ have been carried out, which indicate the occurrence of a miscibility gap¹⁰ in the x = 0.12 to x = 1 composition range, the destruction of a stripelike magnetic order¹¹ at x = 0.102, etc., but the resistivity versus temperature in these Fe-rich samples for $(x \sim 0.1)$ is seen to have an insulating behavior.^{10,11} Here, we provide definitive evidence for metallization of single crystals of BaMn₂As₂ under the application of an external pressure of \sim 5 GPa using low-temperature resistivity measurements in a high-pressure cell. Also associated with metallization at 5.8 GPa is a sharp fall in resistivity, seen at \sim 17 K indicating a possibility of superconductivity in this compound. Further, from the measurements of room temperature lattice parameter variations as a function of pressure in the BaMn₂As₂ crystals, we show an anomalous change in the pressure-volume curve at the pressure at which metallization is seen in the resistivity data.

BaMn₂As₂ single crystals were synthesized using Ba chunks and pre-prepared MnAs powder precursors without using any flux. MnAs was prepared by heating intimate mixtures of Mn powder and As powders in quartz crucibles in a stainless steel chamber that could be locked under an Ar pressure of 30 bars,¹² very similar to the procedure employed for the synthesis of FeAs powders. Stoichiometric amounts of Ba chunks and MnAs powder were taken in an alumina crucible and sealed in an evacuated quartz tube. The samples were then heated to 1200 °C at a rate of 50 °C per hour and held there for 24 h, and then slow cooled to 800 °C at a rate of 1.5 °C per hour followed by a fast cooling rate of 50 °C up to room temperature. Shiny crystals with flat, platelike morphology were formed with an average size of $1 \times 1 \times 1$ 0.4 mm [see Fig. 1(a)]. The composition of the crystals, determined by energy dispersive x-ray (EDX) attachment of a scanning electron microscope, was consistent with BaMn₂As₂ stoichiometry, and also indicated the absence of any other elements [see Fig. 1(c)], implying no contamination from the crucibles. The ambient x-ray diffraction (XRD) pattern of the powdered crystals were measured using Mo $K\alpha$, in the parallel beam transmission geometry and is shown in Fig. 2. It is evident from the figure that BaMn₂As₂ is phase pure and the small impurity lines could arise from inadvertent contamination from grinding. The XRD pattern could be indexed to tetragonal structure, space group I4/mmm, with lattice parameter values a = 4.1677(5) Å, c = 13.4686(4) Å, and V = 233.94(7) Å³, in good agreement with the previous results.7-9

High-pressure x-ray diffraction (HPXRD) experiments were carried out at room temperature using a Mao-Bell type diamond anvil cell (DAC) in an angle-dispersive mode up to 10 GPa. The sample in the powder form was loaded into a 200- μ m-diameter hole drilled in a stainless steel gasket. A mixture of methanol, ethanol, and water in the volume ratio 16:3:1 was used as a pressure transmitting medium. The incident Mo x-ray beam obtained from a Rigaku ULTRAX (18 kW) rotating anode x-ray generator was monochromatized with graphite monochromator. An image-plate-based



FIG. 1. (Color online) (a) Photographs of the $BaMn_2As_2$ crystals; (b) shows a small region of one of the crystals, in which the energy dispersive x-ray pattern shown in (c) was obtained.

mardtb345 diffractometer was used. The overall resolution of the diffractometer system is $\delta d/d \approx 0.001$. The Mao-Bell type DAC was fitted to the diffractometer and the sample-todetector distance was calibrated using a standard specimen like LaB₆. The equation of state of silver was used as a parameter for pressure calibration. Two-dimensional (2D) image data from the Mar345 IP detector was converted to one-dimensional (1D) intensity versus 2θ plots using the FIT2D program.¹³ A sample XRD pattern carried out in the DAC at 0.34 GPa is displayed in the inset of Fig. 2 Each data set could be indexed with a tetragonal lattice with space group I4/mmm. Accurate lattice parameters were obtained by Rietveld refinements employing the GSAS program.¹⁴ The detector-to-sample distances for ambient and high pressures were different leading to slight changes in resolution seen in the figure.

High-pressure resistivity measurements as a function of temperature in the 4.2–300 K temperature range on a single crystal sample were carried out in a home-built, opposed anvil pressure-locked cell. Steatite was used as the pressure-transmitting medium and pyrophyllite washers were used as the gasket. The high-pressure measurements on BaMn₂As₂ samples were carried out by maintaining similar experimental conditions to those used during pressure calibration. The internal pressure of the cell was precalibrated by measuring the shift in the superconducting transition temperature of lead with respect to the applied load prior to mounting the samples. An error of ~0.2 GPa in the reported pressure can be expected. Further details about the sample assembly and measurements on different samples can be found in Refs. 4, 15, and 16.

Figure 3 shows the temperature variation of resistance from 4.2 to 300 K for representative pressures between 0 and 8.2 GPa. At ambient pressure [cf. Fig. 3(a)] the resistance increases with decrease of temperature characteristic of a semiconductor. We could not measure the resistance below 30 K at ambient pressure as the value exceeded the measurement limit of the instrument. It must be emphasized that no metallic regime was observed in the R(T) data at ambient pressure, in contrast with the observation of metallic behavior seen above 100 K for single crystals of BaMn₂As₂ synthesized by MnAs flux^{7,9} and above 250 K for Sn flux-grown BaMn₂As₂.⁷ These metallic behaviors were attributed to a very small amount of

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FIG. 2. (Color online) XRD pattern at ambient pressure obtained by powdering tiny $BaMn_2As_2$ single crystals embedded in the melt, using Mo x-ray beam and a Rigaku ULTRAX (18 kW) rotating anode x-ray generator, monochromatized with graphite. The plot shows intensity versus 2θ values, of the observed (black +) and the calculated (blue solid line), obtained from Rietveld refinement. The difference (pink solid line) is also shown. In the inset the XRD data obtained in the DAC at 0.34 GPa are shown, along with the those of the pressure calibrant Ag (111) line. Data such as in the inset were used to obtain the lattice parameters shown in Fig. 5.

inclusions of MnAs or Sn into the lattice.^{7,9} At a pressure of 0.8 GPa, the R(T) again showed insulating behavior in the 70-300 K temperature range, although a significant drop in resistance with respect to the ambient pressure data was seen at low temperature. With a further increase in applied pressures to 2.1 and 3.4 GPa [see Figs. 3(b) and 3(c)], the resistance at low temperature decreases, with a discernible two-step variation of R(T). With a further increase in pressure to 4.3 GPa, the variation R(T) shows a change in sign at 36 K, indicating a metallic behavior at low temperature. Thus at this pressure the crystal shows an insulator-to-metal transition as a function of temperature. At 5.8 GPa, R(T) shows a metallic behavior in the whole temperature range of 4.2-300 K. With further increase of pressure from 5.8 to 8.2 GPa, the resistance further reduces at all temperatures, remaining metallic in the temperature range 4.2-300 K. The variation in the resistance as a function of pressure is plotted for 30, 50, and 290 K in Fig. 4(a). The resistance at 30 K is seen to reduce by seven orders of magnitude, at 50 K by five orders of magnitude, and at 290 K by three orders of magnitude with increase in pressure to 8 GPa.

The ambient pressure R(T) data fit to an activated behavior $[\rho = \rho_0 \exp(\Delta/k_B T)]$ in the 70–300 K temperature range. The fitted curve is shown in Fig. 3 as solid red lines. Below 70 K the R(T) data fit to a variable range-hopping transport, probably arising from defect states in the semiconducting gap. Since we are interested in the electronic structure of the bulk we restrict to Arrhenius fits in the 70–300 K temperature range for all pressures. The activation energies obtained from fits of the R(T) data as a function of external pressure are shown in Fig. 4(b). It is evident from the figure that the activation energy shows a systematic decrease with increase in applied



pressure. In particular, it decreases from 38.4 ± 2 meV at ambient pressure to 3 ± 0.2 meV at 4.3 GPa, after which the crystal metallizes. The magnitude of the ambient pressure, semiconducting gap obtained from our data is comparable to that obtained from an earlier report.⁷

In addition to the observation of metallization by the application of pressure at 5.8 GPa, a notable fall in resistance was observed at a temperatures ~ 17 K, which is visible in



FIG. 4. (Color online) (a) Change in resistance with temperature at various pressures to highlight the transition from insulating and metallic behavior at high pressures. (b) The band gap as a function of pressure determined from the Arrhenius fits of the R(T) data in the 70–300 K temperature range.

FIG. 3. (Color online) Resistance versus temperature for BaMn₂As₂ at different pressures between 0 and 8.2 GPa for representative pressures. Left panels indicate the pressure regime in which the sample shows a semiconducting behavior. Red solid lines in Figs. 3(a)–3(d) are fits to $\rho = \rho_0 \exp(\Delta/k_BT)$ in the 70–300 K temperature range. The right panel shows R(T) in the pressure regime in which the sample shows metallicity. Inset of Fig. 3(g) shows the current dependence of the fall in resistance at 17 K.

all graphs in the right panel of Fig. 3. The magnitude of the fall in resistance increases with increase of pressure and it is more clearly seen in the R(T) measured at the highest applied pressure of 8.2 GPa. The fall in resistivity is shown in expanded form in the inset of Fig. 3(g). It is clear from the figure that there is a current-dependent broadening in the onset of the fall in the resistivity. Such a current-dependent shift was seen to occur in single crystals of BaFe₂As₂ at \sim 3.5 GPa, preceding the stabilization of a more robust superconducting state at ~ 6.4 GPa, where no current dependence was seen.¹⁷ Our results shown in the inset of Fig. 3(g), seen in light of those in Ref. 17, could imply that superconductivity occurs in a small fraction of the sample at \sim 8 GPa and that superconductivity could be more robust at higher pressures. Unfortunately, the experiments could not be done at higher pressure to provide unambiguous evidence for a superconducting transition on account of the limitation of the pressure cell. High-pressure, low-temperature magnetization experiments, to confirm diamagnetism associated with the superconductinglike anomaly seen from 5.8 GPa will be useful.

In light of the observation of metallization of BaMn₂As₂ (cf. Fig. 3), we have carried out high-pressure powder XRD measurements at room temperature, to see if the metallization is associated with a structural transition. The measured variation of the *a* and *c* lattice parameters with external pressure are shown in Fig. 5(a). While both the lattice parameters a and c decrease monotonically with increasing pressure, there is a distinct change in the pressure variation of lattice parameters, with a crossover region at ~ 5 GPa. The lattice parameter a becomes less compressible at higher pressures, whereas the compressibility of the lattice parameter c shows a slight increase. The cube of the individual lattice parameters could be fitted to a third-order Birch-Murnaghan (BM) equation of state (EOS) and the zero-pressure compressibilities (β_{a0}) of individual lattice parameters are indicated in Fig. 5. The structural parameter of importance in the arsenide system is the c/a parameter,¹⁸ and Fig. 5(b) shows the variation of



FIG. 5. (Color online) (a) The tetragonal lattice cell parameters of $BaMn_2As_2$, *a* and *c*, versus applied pressure. (b) The *c/a* ratio versus pressure plot. (c) Unit cell volume versus pressure data. The solid lines are the third-order fits to the Birch-Murnaghan equation of state (see text for details). The refined values of the zero-pressure volumes as well as the bulk modulus are shown in the figure. The dotted lines in (a) and (c) are guides to the eye.

the c/a ratio as a function of pressure. The magnitude of c/a and its smooth variation with pressure indicates that the metallization observed in the present study is not associated with the collapsed tetragonal phase. Figure 5(c) shows the

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lattice volume versus pressure, and the fits to the third-order Birch-Murnaghan equation of state. The difference in the compressibility behavior for the low-pressure insulating phase and high-pressure metallic phase can be clearly seen, with a crossover at 5 GPa. The significance of the above pressure data can also be appreciated in the context of efforts¹⁰ to metallize BaMn₂As₂ through substitutions.

The room temperature cell volume¹ in BaT₂As₂, where *T* is a 3*d* transition element from Cr to Cu, shows an anomalous increase at T = Mn, that is linked to its high spin state. It is noteworthy that the cell volumes observed upon metallization of BaMn₂As₂ are very close to the cell volumes of metallic BaCr₂As₂ and BaFe₂As₂, both of which are itinerant antiferromagnets. These observations suggest that cell volume plays a crucial role in the stabilization of the metallic state in this system.

The insulator-to-metal transition (cf. Fig. 3), that is associated with an isostructural transition (cf. Fig. 5) points to an electronic topological transition induced by pressure. Isostructural transitions have been observed in many insulating and semiconducting systems where volume anomalies correspond to electronic topological transitions (ETT) involving large variation in the density of states at Fermi level.¹⁹ The occurrence of ETT has also been invoked in the arsenide family.²⁰ Band structure calculations would be worthwhile to elucidate the nature of the electronic transition, and also studies on the evolution of the magnetic state of BaMn₂As₂ as it metallizes under the application of pressure.

In conclusion, we have demonstrated metallization of the G-type antiferromagnetic BaMn₂As₂ under an application of pressure of ~5 GPa. High-pressure XRD measurements at room temperature show that this insulator-to-metal transition is associated with an isostructural electronic transition. The observed pressure-induced metallization of BaMn₂As₂ would help in fine-tuning the on-going efforts on metallization with chemical substitutions. The metallic phase has a sharp drop in resistance at 17 K, suggestive of a superconducting transition.

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